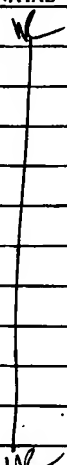
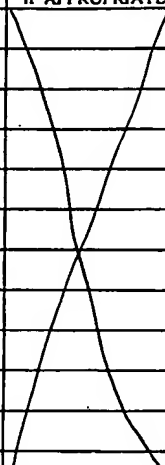


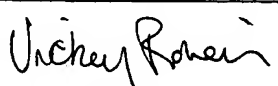


LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)					ATTY DOCKET NO. 11419-003-999		APPLICATION NO To Be Assigned	
					APPLICANT Yang et al.			
					FILING DATE December 4, 2003		GROUP To Be Assigned	
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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
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	C01	Kirk-Othmer Encyc. of Chem. Technol., 3 ^d Ed. 1980), John Wiley & Sons, New York 11:963-971
	C02	Kirk-Othmer Encyc. of Chem. Technol., (4 th Ed. 1997), John Wiley & Sons, New York 23:483-541

EXAMINER 	DATE CONSIDERED 7-7-05
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and-not considered. Include copy of this form with next communication to applicant.</small>	